Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/725,242	YOSHIOKA ET AL.	
Examiner	Art Unit	
Vanel Frenel	3626	

	SEAR	CHED	
Class	Subclass	Date	Examiner
705	4	7/8/2006	V.F
	-		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
West 2.0		7/8/2008	V.F		